

**Notice of References Cited**

Application/Control No.

10/622,841

Applicant(s)/Patent Under  
Reexamination  
SRINIVASAN ET AL.

Examiner

CHIKAODILI E. ANYIKIRE

Art Unit

2482

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,144,426 A	09-1992	Tanaka et al.	375/240.13
*	B	US-5,227,878 A	07-1993	Puri et al.	375/240.15
*	C	US-5,386,234 A	01-1995	Veltman et al.	375/240.13
*	D	US-5,550,847 A	08-1996	Zhu, Qin-Fan	714/748
*	E	US-5,650,829 A	07-1997	Sugimoto et al.	348/699
*	F	US-5,694,173 A	12-1997	Kimura et al.	348/423.1
*	G	US-5,734,783 A	03-1998	Shimoda et al.	386/68
*	H	US-2002/0106025 A1	08-2002	Tsukagoshi et al.	375/240.16
*	I	US-2003/0059118 A1	03-2003	Suzuki, Kojiro	382/233
*	J	US-7,486,734 B2	02-2009	Machida, Yutaka	375/240.25
*	K	US-5,835,144	11-1998	Matsumura et al.	375/240.23
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	W					
	X					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.